

Notice of References Cited	Application/Control No. 10/041,146	Applicant(s)/Patent Under Reexamination BERTHOUD, CHARLES W.	
	Examiner Tse Chen	Art Unit 2116	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,308,215 B1	10-2001	Kolbet et al.	709/233
	B	US-6,363,085 B1	03-2002	Samuels, James Vincent	370/502
	C	US-6,542,946 B1	04-2003	Wooten, David R.	710/106
	D	US-4,402,271	09-1983	Heidmann et al.	102/362
	E	US-5,469,746	11-1995	Fukunaga et al.	73/861.12
	F	US-5,365,577	11-1994	Davis et al.	379/93.17
	G	US-2003/0026183	02-2003	Kitagawa, Masayuki	369/53.3
	H	US-4,491,007	01-1985	Crowdes, Jr., George J.	73/1.37
	I	US-4,768,926	09-1988	Gilbert, Jr., Billy D.	416/61
	J	US-5,631,758	05-1997	Knox et al.	398/75
	K	US-6,460,094	10-2002	Hanson et al.	710/8
	L	US-6,393,588	05-2002	Hsu et al.	714/43
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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